

Search Notes

Application/Control No.

10/780,148

Examiner

Binh X. Tran

Applicant(s)/Patent under
Reexamination

KAISE ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
216	24	12/9/2005	BT
216	26	12/9/2005	BT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search inventor's name and keywords using USPAT, USPG-PUB, JPO, EPO	12/9/2005	BT